

Conductance of a Quantum Point Contact in the presence of a Scanning Probe Microscope Tip

Guang-Ping He¹, Shi-Liang Zhu^{2,3}, and Z.D. Wang^{2,4,5}

¹Advanced Research Center, Zhongshan University, Guangzhou 510275, China

²Department of Physics, University of Hong Kong, Pokfulam Road, Hong Kong, China

³Department of Physics, South China Normal University, Guangzhou 510631, China

⁴Department of Material Science and Engineering, University of Science and Technology of China, Hefei, China

⁵Texas Center for Superconductivity, University of Houston, Texas 77204, USA

Using the recursive Green's function technique, we study the coherent electron conductance of a quantum point contact in the presence of a scanning probe microscope tip. Images of the coherent fringe inside a quantum point contact for different widths are obtained. It is found that the conductance of a specific channel is reduced while other channels are not affected as long as the tip is located at the positions corresponding to that channel. Moreover, the coherent fringe is smoothed out by increasing the temperature or the voltage across the device. Our results are consistent with the experiments reported by Topinka et al. (Science 289, 2323 (2000)).

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Quantum point contacts (QPCs) formed in two-dimensional electron gases (2DEGs) have attracted significant attention for the past two decades.^{1,2} Since the discovery of the conductance quantization in these structures,¹ QPCs have been widely used in a variety of investigations, including transport through quantum dots, the quantum Hall effect, magnetic focusing, and the Aharonov-Bohm effect.² Also, with the rapid development on scanning probe microscope (SPM) techniques, it is possible to image current directly to study many remarkable phenomena, including quantum corals,³ electron flow through nanostructures,⁴ charge distribution and photoactivity of dopant atoms,⁵ and spectra of metallic nanoclusters.⁶ Since the QPC plays such an important role in mesoscopic devices, it is an ideal system to be studied by the SPM techniques.

Very recently, Topinka et al. have directly imaged the electron flow from the QPC by scanning a negatively charged SPM tip above the surface of the device and measuring the position-dependent conductance simultaneously.^{7,8} In the experiment, as the width of the QPC increases, the conductance increases in quantized steps of $2e^2/h$, as was also reported in other experiments.¹ Besides, several new and interesting features were observed. Widening of the angular structure of electron flow has been clearly seen as the QPC channel becomes wider. Another feature of their images is the appearance of fringes spaced by half the Fermi wavelength transverse to the electron flow, which clearly shows the character of coherent quantum interference. The above fringes are thermally smeared out by increasing the effective electron temperature. Moreover, when the tip is placed such that it interrupts the flow from particular modes of the QPC, a reduction can be observed in the conductance of those channels, while other channels are not affected.⁷ On the other hand, it is also found that, in contrary to intuitions, the electron flow from the

point contact forms narrow branching strands instead of smoothly spreading fans.⁸

Using the recursive Green's function technique, in this paper, we study theoretically a mesoscopic structure similar to the experimental one.^{7,8} Our numerical results are able to explain the experimental finding in Refs.7,8. Therefore, the recursive Green's function technique seems to be a suitable method to study the coherent electron conductance in such a mesoscopic system.

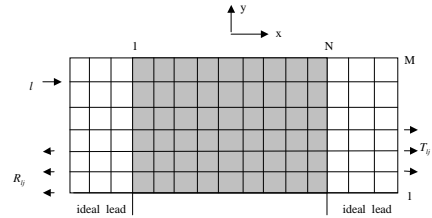


Fig.1

FIG. 1. Schematic diagram of the system.

We consider a negatively charged SPM tip capacitively coupled to the 2DEG where the QPC is formed. The effect of SPM tip is that, the conductance will decrease if the tip is positioned over regions with high electron flow from the QPC, while it will be less modified if the tip is at low electron flow regions. The electron flow can be imaged by scanning the tip over the two-dimensional surface. Two contributions to the potential in the 2DEG region should be taken into account. One is

from the negatively charged gates that define the QPC, which we model with the Buttiker saddle-point potential $U(x; y) = V_g - m \frac{1}{2} x^2 = 2 + m \frac{1}{2} y^2 = 2$ with V_g as the gate voltage, m as the electron effective mass and $\frac{1}{2} x, y$ as the strength of the lateral confinement. This potential is a practical candidate to reproduce the quantized conductance of a QPC.⁹ The other is a Lorentzian type potential induced by the SPM tip,¹⁰ which we approximate as a delta function in the present work: $V_{SPM} = V_t (\delta(x - x_t))$, where x_t denotes the position of the tip, and V_t is a negative constant. It is worth noting that the numerical results obtained with the simple delta potential are consistent with the experimental results.^{7,8}

We use a 2D square lattice model to describe the QPC system. The sites of the lattice are denoted as $(n; m)$ with n to be set equal to unit, $n = 1; 2; \dots; N$ and $m = 1; 2; \dots; M$. The lattice may be divided into three regions, as shown in Fig.1. The shadowed central zone is a mesoscopic structure with a Buttiker saddle-point potential and scanned by a SPM tip. Both sides of the structure are assumed to be connected with semi-infinite ideal leads to simplify scattering boundary conditions. The one-electron tight-binding Hamiltonian of the system takes the form¹¹

$$H = \sum_{n,m} \sum_{n',m'} t_{n,m;n',m'} c_{n,m}^\dagger c_{n',m'} + \sum_{n,m} \epsilon_{n,m} c_{n,m}^\dagger c_{n,m} \quad (1)$$

where $t = \hbar^2/2ma^2$ and $\{c_{n,m}\}$ is an orthonormal set in the lattice sites $(n; m)$. The on-site energy in the central zone is given by $\epsilon_{n,m} = U_{n,m} + V_{SPM} + 4t$. Then the Hamiltonian for this region reads

$$H_c = \sum_{n=1}^N \sum_{m=1}^M \epsilon_{n,m} c_{n,m}^\dagger c_{n,m} + \sum_{n=1}^N \sum_{m=1}^M t_{n,m;n+1,m} c_{n,m}^\dagger c_{n+1,m} + \text{h.c.} \quad (2)$$

where $\{c_{n,m}\}$ denotes the set of M ket vectors belonging to the n -th cell, and

$$H_{n,n+1} = \begin{pmatrix} t & 0 & \dots & 0 \\ 0 & t & \dots & 0 \\ \vdots & \vdots & \ddots & \vdots \\ 0 & 0 & \dots & t \end{pmatrix}_{M \times M}$$

$$(H_{n,n-1})_{pp^0} = (H_{n,n+1})_{pp^0} = t_{pp^0} \quad (p; p^0 = 1; \dots; M)$$

The Hamiltonians for the two ideal leads have the same form as Eq.(2), but with different summing regions ($1 < n < N$ at the left lead and $N < n < N+1$ at the right lead) and $\epsilon_{n,m} = 4t$.

Using the recursive Green's function technique, the transmission amplitude for the incident channel l and outgoing channel j is found to be^{11,12}

$$t_{lj} = \frac{q}{v_j} \frac{1}{v_j} G_{N+1,0}^+(E) e^{ik_j L_x} \quad (3)$$

where $v_j = \partial E / \partial k_j$ with $E = 4t - 2t(\cos k_j + \cos j\pi / (M+1))$, $G_{N+1,0}^+(E) = 2it \sum_{l=1}^M Q_l \sin k_l$ with

$$(Q_l)_{pp^0} = \frac{2}{M+1} \sin \frac{lp}{M+1} \sin \frac{lp^0}{M+1}; \quad (p; p^0 = 1; \dots; M)$$

The set of vectors $\{Q_l\}$ are the duals of the set $\{k_l\}$, defined by $\sum_{k_j} Q_l = \delta_{jl}$ where

$$Q_l = \frac{2}{M+1} \left(\sin \frac{lj}{M+1}; \dots; \sin \frac{lm}{M+1}; \dots; \sin \frac{lM}{M+1} \right)^T$$

with T as the transposition of matrix. $G_{N+1,0}^+$ is the retarded Green's function for the scattering region between two ideal leads, which can be obtained by a set of recursion formulas in a matrix form,^{12,13}

$$G_{n^0+1,0} = t g^{n^0+1} G_{n^0,0}; \quad (0 \leq n^0 \leq N) \quad (4)$$

$$g^{n^0+1} = (E - \mathbb{H}_{n^0+1} - t^2 g^{n^0})^{-1}; \quad (5)$$

by iteration starting from $g^0 = G_{0,0} = (E - \mathbb{H}_0)^{-1}$, where $\mathbb{H}_1 = H_1 (1 \times 1 \text{ matrix})$, and $\mathbb{H} = H \sum_{j=1}^M e^{ik_j} Q_j$ ($= 0; N+1$).

At finite temperature T , the conductance through a 2D mesoscopic structure is given by the Landauer-Buttiker formula¹⁴

$$G(T) = \frac{2e^2}{h} \sum_{l,j} T_{lj} \frac{\partial f(E; T)}{\partial E} \quad (6)$$

where $T_{lj} = |t_{lj}|^2$ is the transmission coefficient, and $f(E; T) = [1 + \exp((E - E_F)/k_B T)]^{-1}$ is the Fermi-Dirac distribution with E_F as the Fermi energy and k_B as the Boltzmann constant. Obviously, at zero temperature Eq.(6) reduces to $G = 2e^2/h \sum_{l,j} T_{lj}$.

The above formulas are valid under the assumption that the voltage across the device is low. High voltage will raise the energies of electrons owing from the QPC. Thus, as shown by van Wees et al.,¹⁵ the conductance at a finite voltage V has a similar behavior to that with a finite temperature effect, and is given by

$$G(V) = \frac{2e^2}{h} \sum_{l,j} T_{lj} \frac{\partial f(E_F + eV)}{\partial E} \quad (7)$$

In the following we calculate numerically the conductance of a QPC system with the size $N = 15$ and $M = 11$. We set t and the lattice constant a as the units of energy and length, respectively. In order to obtain well-pronounced quantized plateaus with the Buttiker saddle-point potential, we choose $\frac{1}{2} = 2\frac{1}{2}$, $E_F = 2t$, and $V_t = 1.5t$.

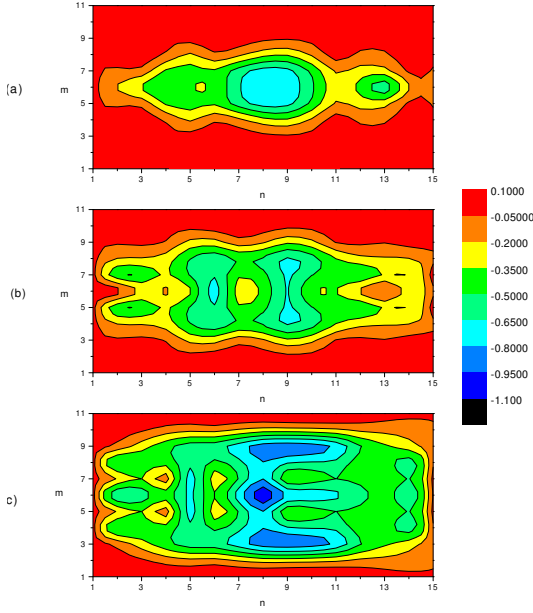


Fig.2

FIG. 2. Images of electron flow across a QPC at zero temperature and low voltage for three different widths corresponding to (a) the first conductance plateau, $V_g = 0.7E_F$; (b) the second plateau, $V_g = 0.4E_F$; (c) the third plateau, $V_g = 0.2E_F$. The color scale shows the change $G = G - G_0$ in QPC conductance as the tip is scanned above the device.

At zero temperature and low voltage limit, images of electron flow from the 2D surface of the QPC are plotted in Fig.2. The gate voltage V_g is chosen to ensure Fig.2 (a) - (c) correspond to the first, the second and the third conductance plateau of the QPC, respectively. It is seen clearly that a new electron flow pattern appears when a higher mode is opened (then the conductance of the QPC rises to another plateau) by decreasing the gate voltage. This feature agrees with the result reported in Ref.7: electronic wavefunctions inside the QPC have N maxima when QPC has N conductance modes. Note that the images do not turn into smoothly spreading fans as the electrons flow across the QPC from the left to the right. Instead, they form branching strands which are relatively narrower. In fact, even the width of the sample decreases to $M = 6$ in the calculation, the images change little (not shown here). It is not surprising that strands are formed in our model since the electrons are laterally confined. On the other hand, a similar but also striking phenomenon is reported in Ref.8, where the strands were found in regions far away from the point contact. So we can see that the electron path has a rare probability to pass through the edge regions of the sample, and thus the impurity density and the boundary scattering in these re-

gions are less relevant to the conducting property of the QPC. Moreover, the fringe structures due to the alternating constructive and destructive interference of electrons are evident in Fig.2, though the distribution is not so homogeneous when compared with the experiments.⁷ This inhomogeneity induced from the varieties of electron wavelength inside the QPC is the main difference between the structure of fringe inside and outside QPC. It is worth pointing out that the fringes directly demonstrate the coherent character of electron flow in QPC.

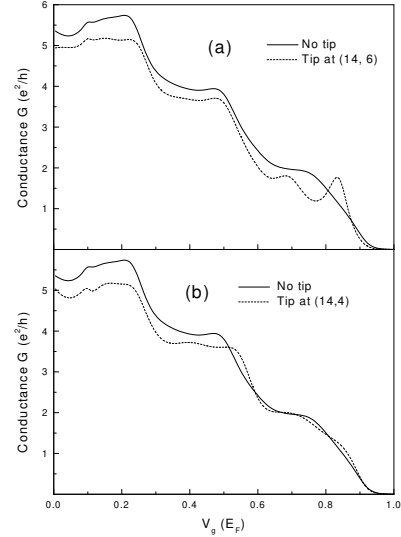


Fig.3

FIG. 3. The conductance plateaus of the QPC for the selective effect of the SPM tip. The solid line represents the curve without SPM tip, and the dash line is the curve with the SPM placed over certain position such that it blocks the electron flow from (a) the first mode, or (b) the second mode.

Meanwhile, we also note that the angular structures in these electron flow patterns are quite different from each other, especially for the first and second modes. For the first mode, the pattern contains one branch only, while there are two branches for the second mode. So there are some regions in the 2D surface where the distribution of electrons at one mode make no contribution to the other mode. As reported in experiments,⁷ when the SPM tip is placed over these regions, only the flow from particular channels of the QPC are changed, while other channels are not affected. This phenomenon is clearly manifested in Fig.3, where the quantized $G - V_g$ curves of the QPC with or without the SPM tip are plotted. From the comparison between the behaviors of the solid line and the

dash line in Fig.3(a), we can see that when the tip is placed at the central axis of the QPC where the electrons from the first mode travel through, the heights of all plateaus are reduced. But the height difference between each pair of neighboring plateaus remains to be $2e^2/h$, except for that between the first plateaus and the 0-axis. In Fig.3(b), the SPM tip is positioned on the central axis. According to Fig.2(a) and (b), we can learn that this position corresponds to $G = 0$ in the first mode, and it only affects the second mode. Thus in Fig.3(b) it is shown that the first conductance plateau is almost unchanged, and the second and other higher plateaus are lowered. Again, the height difference between the second and the third plateaus still remains to be $2e^2/h$.

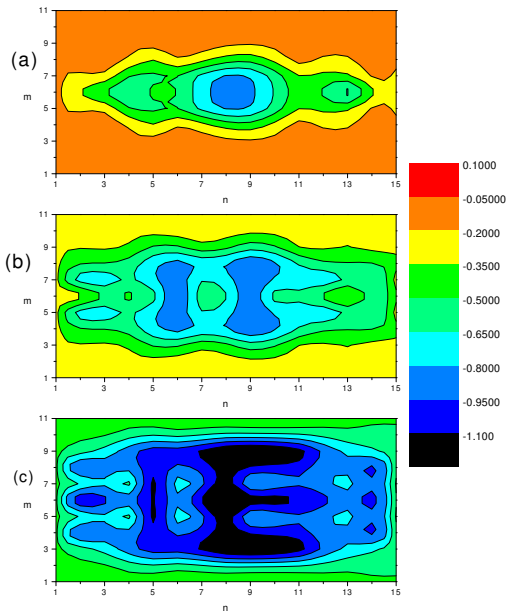


Fig.4(a,b,c)

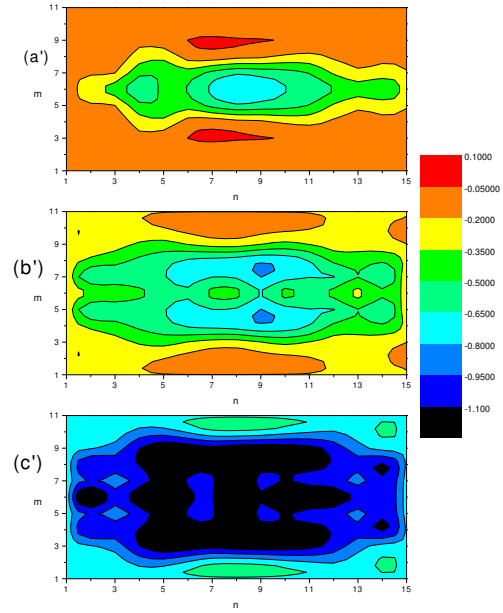


Fig.4(a',b',c')

FIG. 4. Effect of electron heating on images of flow. (a-c) show electron flow for the first, second and third conductance plateaus under the voltage $eV = 0.05t$. (a' - c') show corresponding images for higher voltage $eV = 0.2t$. Other parameters are the same as those in Fig.2.

The electron flows under the finite voltages across the QPC are imaged in Fig.4, where (a - c) are at a low voltage ($eV = 0.05t$) and (a' - c') are at a high voltage ($eV = 0.2t$). Comparing it with Fig.2, we see that the pattern still remains the same in each mode, but the values of G is no longer so severely fluctuated when the voltage is raised. A more important characteristic of voltage effect is that fringe structure would gradually disappear as the voltage rises. Actually, we find that the three conductance modes gradually merge into one conductance mode, which implies that the quantized plateaus also disappear as the voltage is increased. The origin of the fringes is the coherent quantum interference.⁷ Since the fringes are less perceptible as the fluctuation of G becomes pacified, it is manifested that the consequence of using effectively hotter electrons is to smear out the coherence among electrons. The above properties are similar for elevating temperature as the physical effects of temperature and voltage are the same here.¹⁵ Clearly, the voltage effect addressed here is in qualitative agreement with the experimental observation.⁷

In conclusion, we have calculated the conductance of a QPC in the presence of the SPM tip by the recursive Green's function technique. The numerical results are able to explain the experimental results in Refs.7,8.

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